

## FEATURES

- 100% EAS Test
- Super high density cell design
- Extremely Low Intrinsic Capacitances
- Remarkable Switching Characteristics
- Extended Safe Operating Area
- Lower  $R_{DS(ON)}$  : 5.8 mΩ (Typ.) @  $V_{GS}=10V$

## APPLICATION

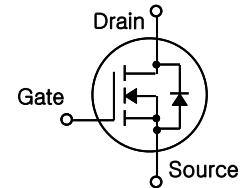
- DC Motor control for E-bike & Power tools
- Amplifier and car booster
- Load Switch
- DC-DC converters

## PFP160N10S/PFB160N10S 100V N-Channel MOSFET

**$BV_{DSS} = 100\text{ V}$**

**$R_{DS(on)} = 5.8\text{ m}\Omega$**

**$I_D = 152\text{ A}$**



**TO-220**



1.Gate 2.Drain 3.Source

**D2-PAK**



1.Gate 2.Drain 3.Source

## Absolute Maximum Ratings

$T_j=25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	Value	Units
$V_{DSS}$	Drain-Source Voltage	100	V
$V_{GSS}$	Gate-Source Voltage	$\pm 25$	V
$I_D$	Continuous Drain Current ( $T_C = 25^\circ\text{C}$ )	152	A
	Continuous Drain Current ( $T_C = 100^\circ\text{C}$ )	107	A
$I_{DM}$	Pulsed Drain Current	608	A
$E_{AS}$	Single Pulsed Avalanche Energy	1400	mJ
$P_D$	Maximum Power Dissipation ( $T_C = 25^\circ\text{C}$ )	300	W
	Maximum Power Dissipation ( $T_C = 70^\circ\text{C}$ )	210	W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.5	$^\circ\text{C}/\text{W}$
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +175	$^\circ\text{C}$
$T_L$	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	$^\circ\text{C}$

**Electrical Characteristics**  $T_c=25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
<b>On Characteristics</b>						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \mu\text{A}$	2.0	--	4.0	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}$ , $I_D = 90 \text{ A}$ , $T_c = 25^\circ\text{C}$ $T_c = 125^\circ\text{C}$	--	5.8 9.4	6.5 10.5	$\text{m}\Omega$
<b>Off Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}$ , $I_D = 250 \mu\text{A}$	100	--	--	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 100 \text{ V}$ , $V_{GS} = 0 \text{ V}$	--	--	1	$\mu\text{A}$
$I_{GSSF}$	Gate-Body Leakage Current, Forward	$V_{GS} = 25 \text{ V}$ , $V_{DS} = 0 \text{ V}$	--	--	100	$\text{nA}$
$I_{GSSR}$	Gate-Body Leakage Current, Reverse	$V_{GS} = -25 \text{ V}$ , $V_{DS} = 0 \text{ V}$	--	--	-100	$\text{nA}$
$V_{SD}$	Diode Forward Voltage	$I_S = 90 \text{ A}$ , $V_{GS} = 0 \text{ V}$	--	--	1.3	V

**Dynamic Characteristics**

$C_{iss}$	Input Capacitance	$V_{DS}=30 \text{ V}$ , $V_{GS}=0 \text{ V}$ , $f=1.0 \text{ MHz}$	--	7900	--	pF
$C_{oss}$	Output Capacitance		--	780	--	pF
$C_{rss}$	Reverse Transfer Capacitance		--	690	--	pF
$R_g$	Gate Resistance	$V_{DS}=30 \text{ V}$ , $V_{GS}=0 \text{ V}$ , $f=1.0 \text{ MHz}$	--	1.3	--	$\Omega$

**Switching Characteristics**

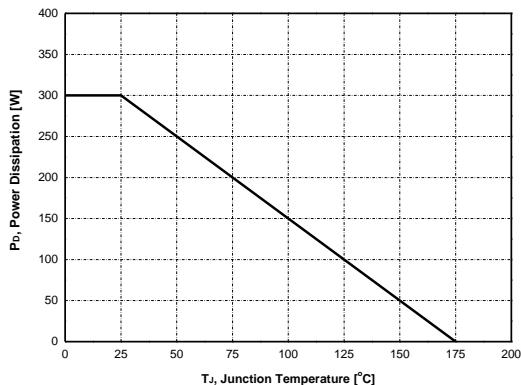
$t_{d(on)}$	Turn-On Time	$V_{DS} = 50 \text{ V}$ , $R_L = 3 \Omega$ $I_D = 90 \text{ A}$ , $V_{GS} = 10 \text{ V}$ , $R_G = 3.3 \Omega$	--	25	--	ns
$t_r$	Turn-On Rise Time		--	40	--	ns
$t_{d(off)}$	Turn-Off Delay Time		--	85	--	ns
$t_f$	Turn-Off Fall Time		--	45	--	ns
$Q_g$	Total Gate Charge	$V_{DS} = 80 \text{ V}$ , $I_D = 90 \text{ A}$ , $V_{GS} = 10 \text{ V}$	--	154	--	nC
$Q_{gs}$	Gate-Source Charge		--	35	--	nC
$Q_{gd}$	Gate-Drain Charge		--	40	--	nC

**Notes :**

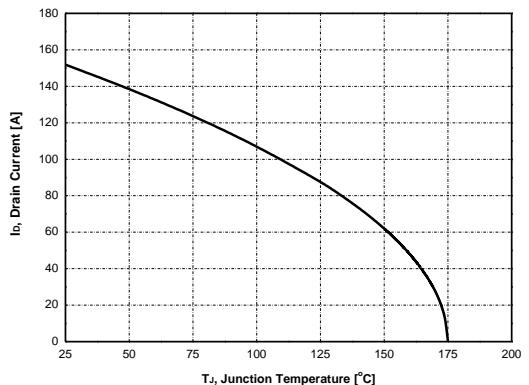
1. Repetitive Rating : Pulse width limited by maximum junction temperature
2.  $L=0.12\text{mH}$ ,  $I_{AS}=152$ ,  $V_{DD}=50\text{V}$ ,  $R_G=25\Omega$ , Starting  $T_J=25^\circ\text{C}$
3. Pulse Test : Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$
4. Essentially Independent of Operating Temperature

## Typical Characteristics

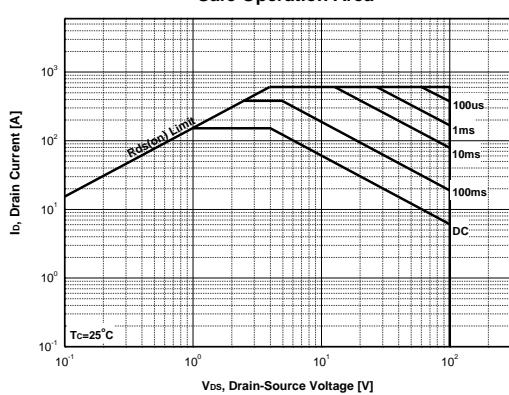
**Power Dissipation**



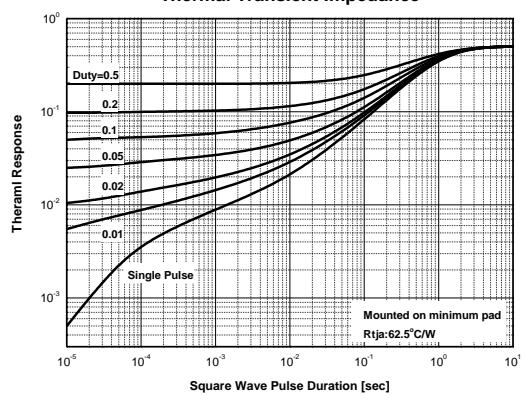
**Drain Current**



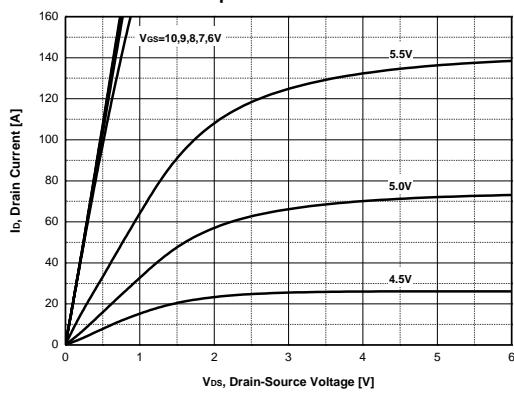
**Safe Operation Area**



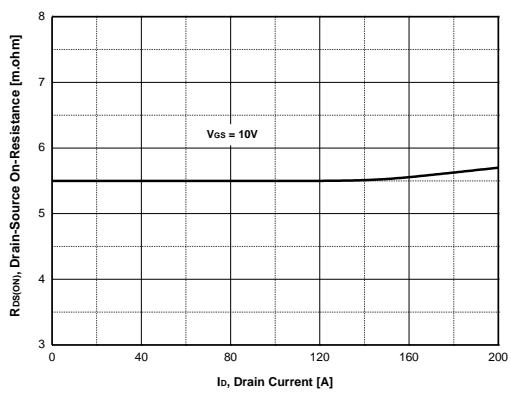
**Thermal Transient Impedance**



**Output Characteristics**

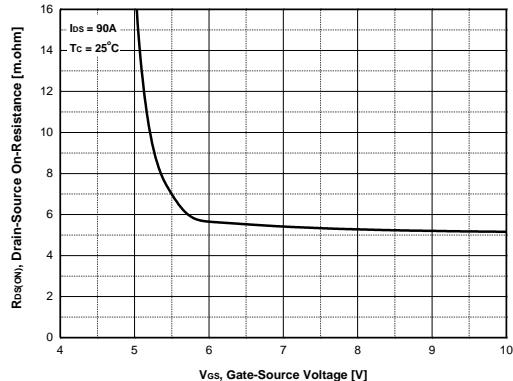


**Drain-Source On Resistance**

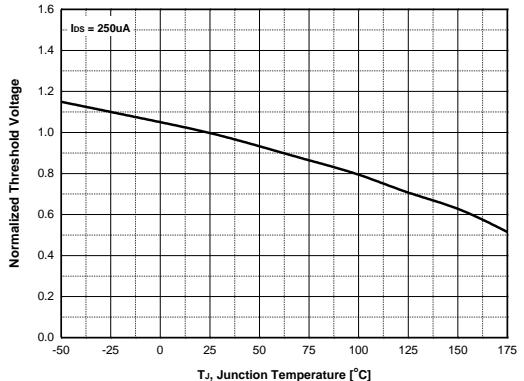


## Typical Characteristics (continued)

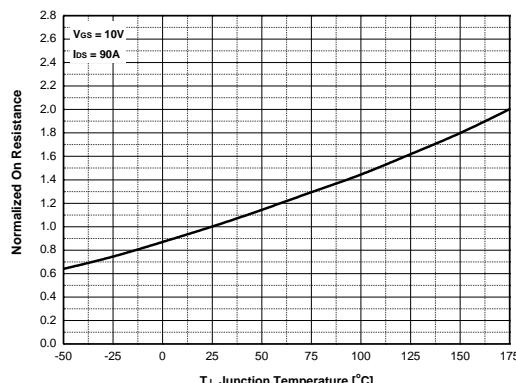
**Drain-Source On Resistance**



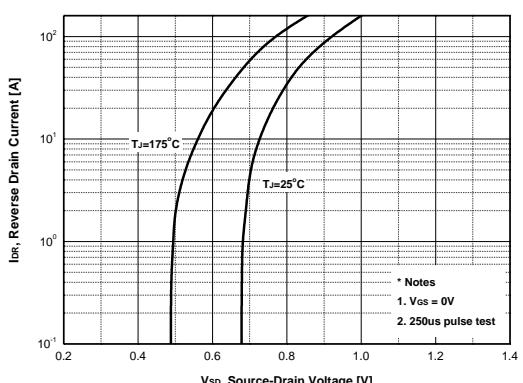
**Gate Threshold Voltage**



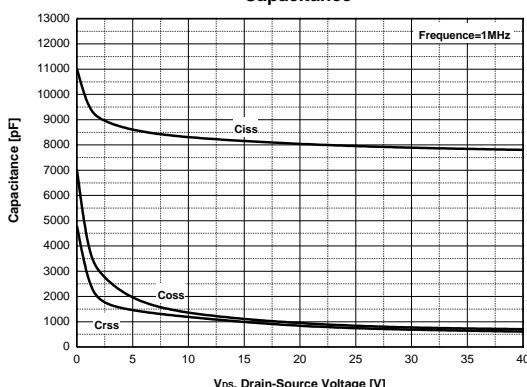
**Drain-Source On Resistance**



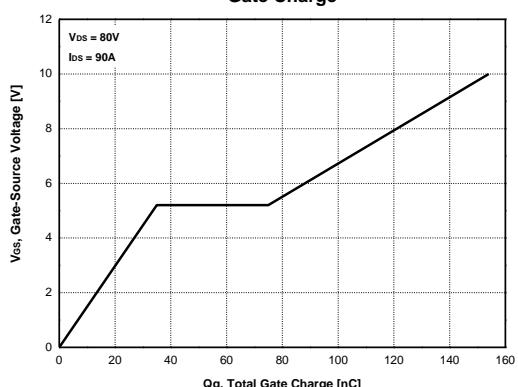
**Source-Drain Diode Forward**



**Capacitance**



**Gate Charge**



## Characteristics Test Circuit & Waveform

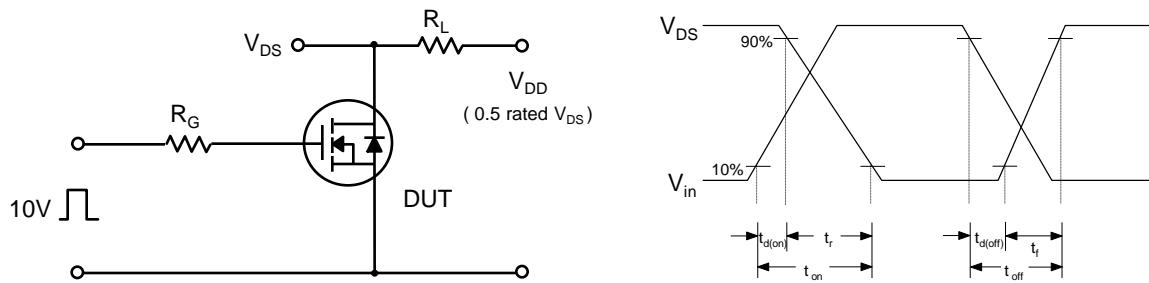


Fig 14. Resistive Switching Test Circuit & Waveforms

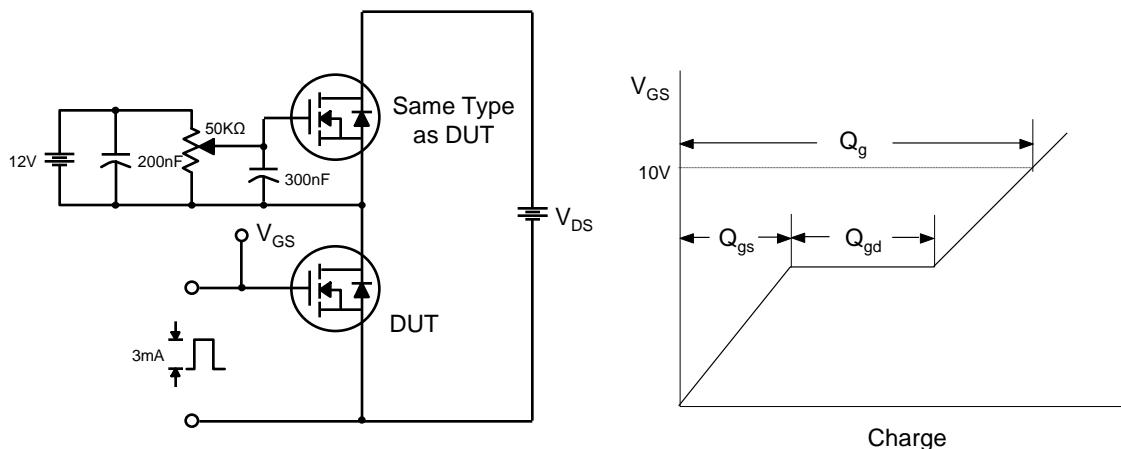


Fig 15. Gate Charge Test Circuit & Waveform

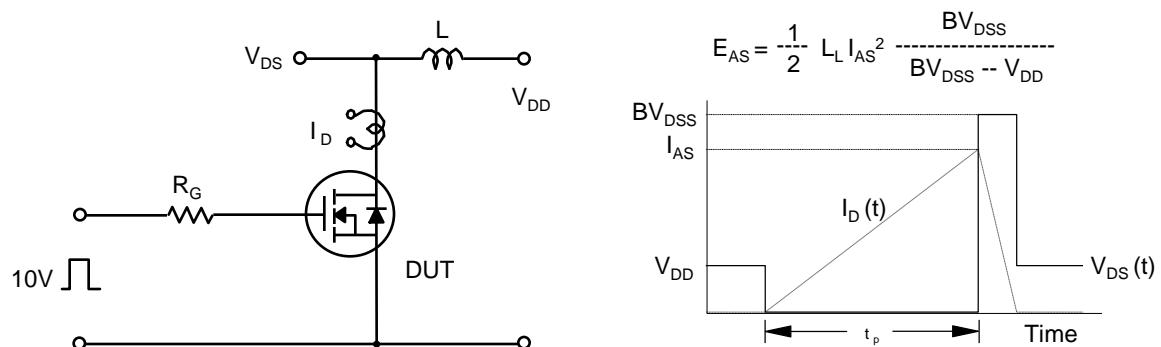


Fig 16. Unclamped Inductive Switching Test Circuit & Waveforms

## Characteristics Test Circuit & Waveform (continued)

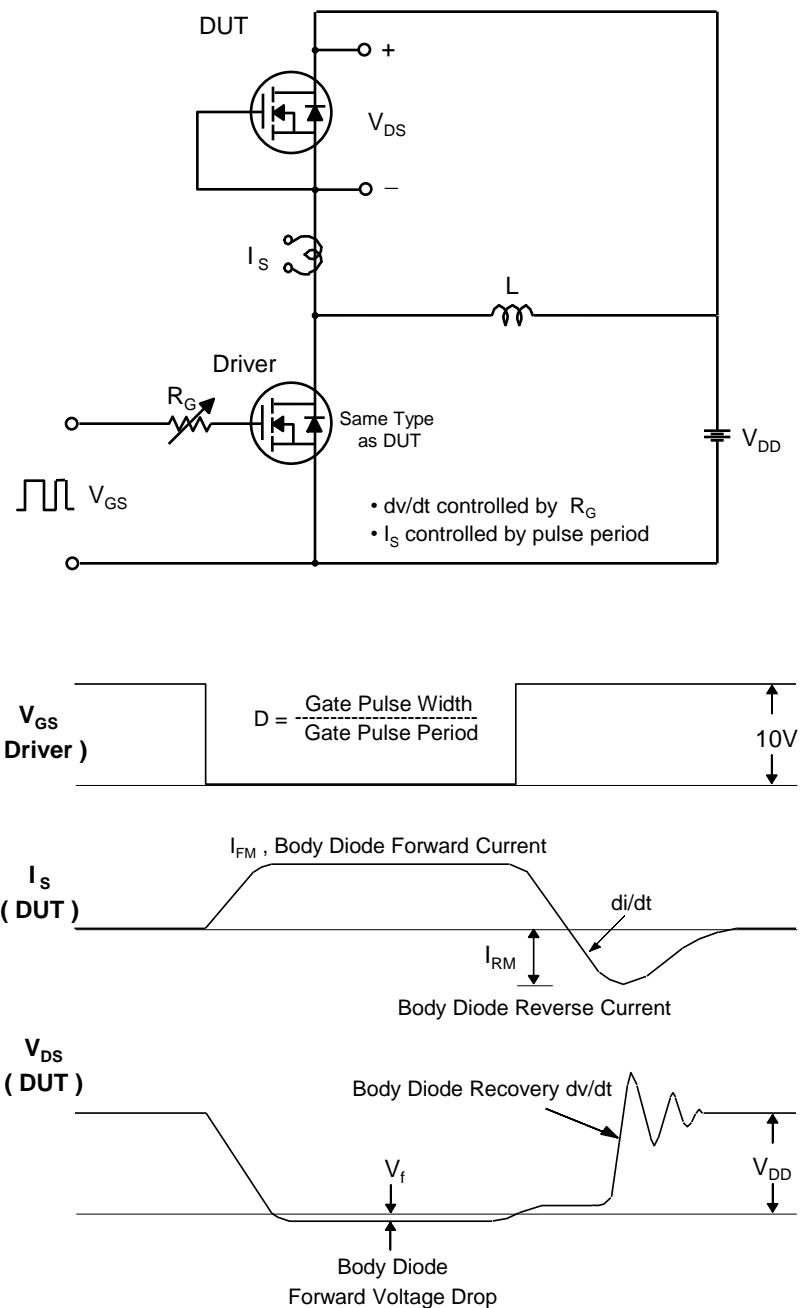
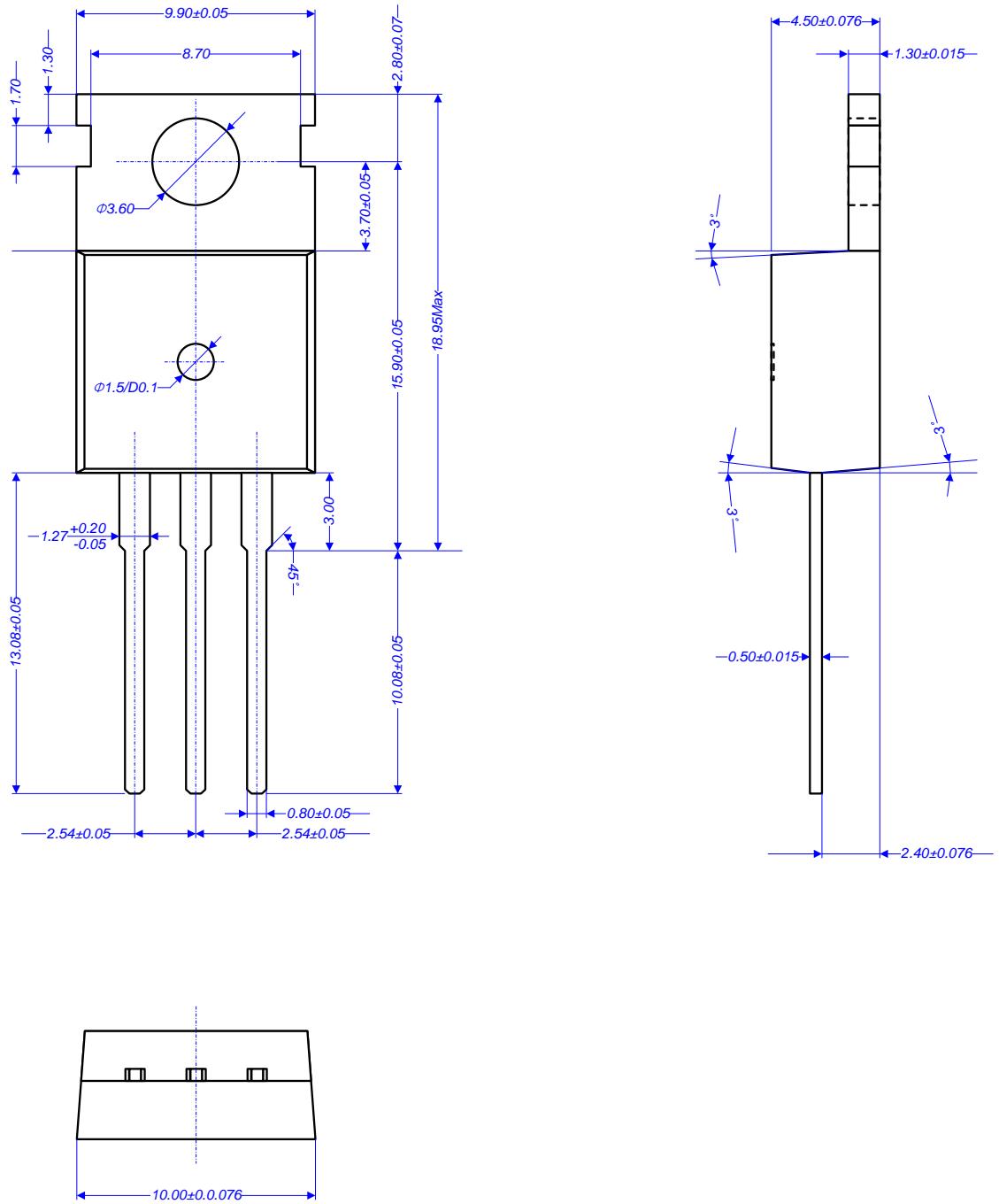


Fig 17. Peak Diode Recovery  $dv/dt$  Test Circuit & Waveforms

**Package Dimension****TO-220**

**Package Dimension****TO-263 (D2-PAK)**